

Effects of Chemical Valences of Sulfur on the Performance of CsFAMA Perovskite Solar Cells

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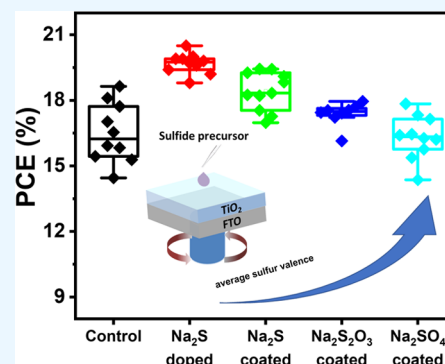
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ABSTRACT: The low electrical conductivity and the high surface defect density of the TiO₂ electron transport layer (ETL) limit the quality of the following perovskite (PVK) layers and the power conversion efficiency (PCE) of corresponding perovskite solar cells (PSCs). Sulfur was reported as an effective element to passivate the TiO₂ layer and improve the PCE of PSCs. In this work, we further investigate the effect of chemical valences of sulfur on the performance of TiO₂/PVK interfaces, CsFAMA PVK layers, and solar cells using TiO₂ ETL layers treated with Na₂S, Na₂S₂O₃, and Na₂SO₄, respectively. Experimental results show that the Na₂S and Na₂S₂O₃ interfacial layers can enlarge the grain size of PVK layers, reduce the defect density at the TiO₂/PVK interface, and improve the device efficiency and stability. Meanwhile, the Na₂SO₄ interfacial layer leads to a smaller perovskite grain size and a slightly degraded TiO₂/PVK interface and device performance. These results indicate that S²⁻ can obviously improve the quality of TiO₂ and PVK layers and TiO₂/PVK interfaces, while SO₄²⁻ has little effects, even negative effects, on PSCs. This work can deepen the understanding of the interaction between sulfur and the PVK layer and may inspire further progress in the surface passivation field.



INTRODUCTION

Organic–inorganic halide perovskite semiconductors boost the certified power conversion efficiencies (PCEs) of perovskite solar cells (PSCs) to a new record of 25.7%¹ due to their outstanding optoelectronic properties including excellent light absorption,^{2,3} long intrinsic photocarrier diffusion length,^{4,5} and high carrier mobility.⁶ The PCE losses mainly originate from the charge recombination within the perovskite layers and at the charge transport layer/PVK interfaces, featured as a much shorter carrier lifetime and a higher trap density.^{7,8} The quality of the ETL/PVK interfaces has been shown to be detrimental to the performance of perovskite optoelectronic devices.⁹

Organic molecules containing various functional groups were chosen to modify the ETL/PVK interface and reduce the nonradiative recombination. van Reenen et al.¹⁰ showed that a thin [6,6]-phenyl-C₆₁-butyric acid methyl ester (PCBM) layer at the TiO₂/PVK interface could efficiently passivate defects and reduce the hysteresis effect and V_{oc} loss. Wang et al. revealed that the formation of interfacial chemical bonds between PCBM and the SnO₂ layer could be resilient to the removal of DMF in the PVK deposition process, which significantly improved the device performance.¹¹ Large molecules with Lewis base functional groups, such as self-assembled fullerene derivatives^{12,13} pyridine,^{14,15} 2-pyridylthiourea,¹⁶ and thiophene,^{17,18} were demonstrated to function as an electron donor to passivate the Pb²⁺-induced traps.

However, part of these molecules may dissolve in antisolvents during the preparation of perovskite layers, which limits their applications.¹⁹

Small molecules with lower cost and better process compatibility were also demonstrated with a similar effect on defect passivation and performance improvement. It has been reported that alkali metal ions such as K⁺ and Na⁺ and halogen ions such as Cl⁻, Br⁻, and I⁻ can modify the electron transport layer and passivate the interface defects, which not only improves the distribution of defects and the binding energy of defects but also promotes interface charge transportation.^{20–24} In addition, many sulfur-based additives were introduced to modify the perovskite from different aspects such as controlling nucleation processes,²⁵ improving phase stability,²⁶ and stabilizing perovskite precursors.²⁷ Han²⁸ et al. demonstrated that the SCN⁻ ions could coordinate with Pb²⁺ ions in the precursor, leading to the improvement of the stability and reduction of the defect density in PVK layers. You³² et al. reported that the carboxyl anions, Na⁺ ions, and sulfurous acid groups in the heparin sodium could interact with under-

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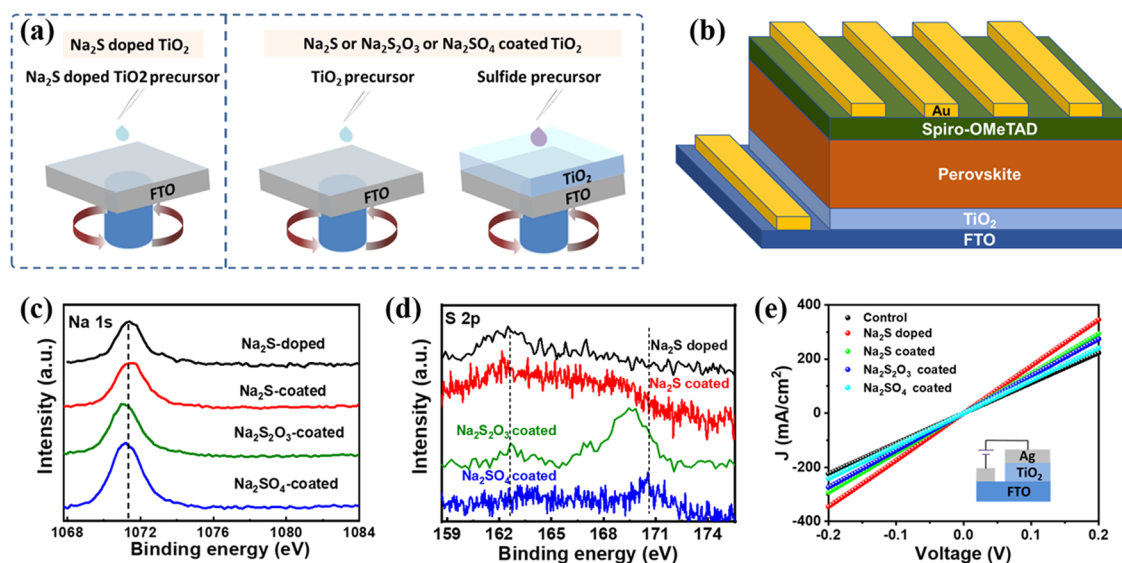


Figure 1. (a) Schematic diagram of the fabrication process of the Na₂S-doped TiO₂ layer (left) and the fabrication process of Na₂S, Na₂S₂O₃, and Na₂SO₄-coated TiO₂ layers (right). (b) Device structure of the planar PSCs. (c) Na 1s and (d) S 2p XPS spectra of compact TiO₂ layers treated with Na₂S, Na₂S₂O₃, and Na₂SO₄. (e) *I*–*V* characteristics of TiO₂ films treated with different Na₂S, Na₂S₂O₃, and Na₂SO₄ sulfides. Inset: device structure for conductivity measurements.

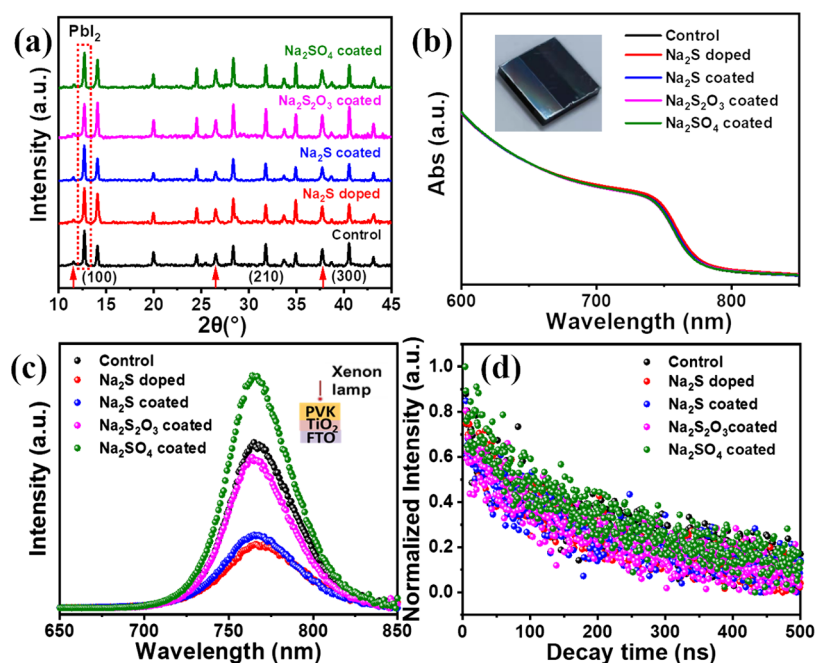


Figure 2. (a) XRD patterns, where the red arrows denote the diffraction peaks of TiO₂, (b) UV–vis spectra (inset: picture of the perovskite film), (c) PL spectra, and (d) TRPL spectra of perovskite films deposited on TiO₂ films treated with Na₂S, Na₂S₂O₃, and Na₂SO₄.

coordinated Pb and I ions, resulting in improved PCE. Our previous work showed that the S²⁻-modified TiO₂ layer could enlarge the grain size and improve the quality of perovskite layers and the PCE.^{29–31} However, S²⁻ can be oxidized to high-valence sulfur during actual operation, while none of the above research studies have discussed the effect of sulfur valence on the performance of PSCs. This inspired us to investigate the effects of sulfur valence on the interface modification of TiO₂ layers and the performance of PSCs.

In this work, we investigated the effect of chemical valences of sulfur on the properties of TiO₂ transport layers and the performances of CsMAFA perovskite solar cells using Na₂S,

Na₂S₂O₃, and Na₂SO₄ solutions to modify the compact TiO₂ substrates. It was found that the Na₂S and Na₂S₂O₃ treatment can not only improve the quality of TiO₂/PVK interfaces but also leads to improved PVK morphology and better device performance with average PCEs of 19.62 and 18.40%. However, only a very limited enhancement was found in the Na₂SO₄-treated samples. The effect of average sulfur valence in sulfides was also discussed subsequently. This work will improve the understanding of the effects of sulfur valence on TiO₂-based PSCs and provide references for the selection of interface passivation chemicals.

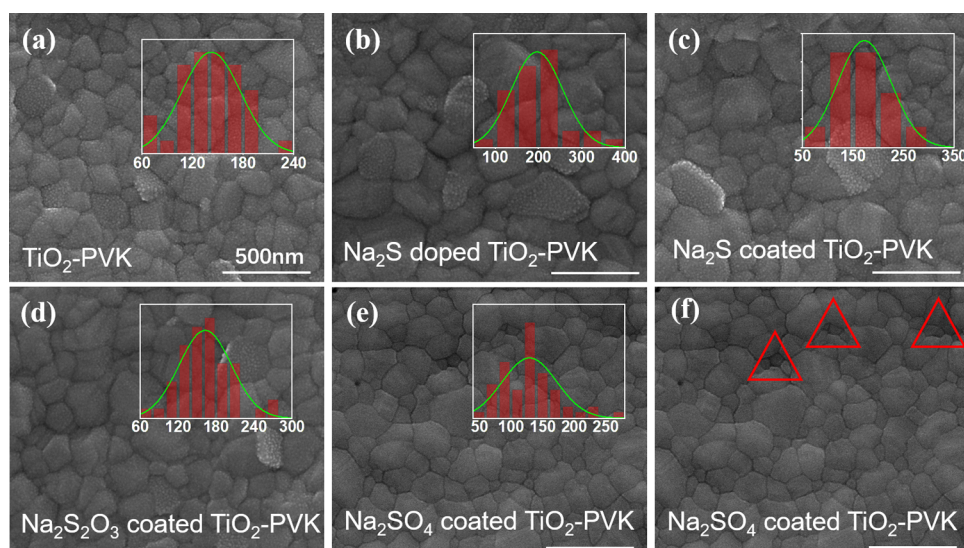


Figure 3. (a)–(e) SEM images of the perovskite films grown on TiO_2 substrates treated with different sulfides and the corresponding grain distribution statistics, where the x -axis represents the grain size. The red triangles in (f) stand for the defects of PVK films.

RESULTS AND DISCUSSION

The TiO_2 layers treated with different sulfides were prepared to investigate the chemical valence effect on the properties of the TiO_2 layer and the TiO_2 /PVK interface using the process shown in Figure 1a. The corresponding samples were denoted Na_2S -doped, Na_2S -coated, $\text{Na}_2\text{S}_2\text{O}_3$ -coated, and Na_2SO_4 -coated, respectively. CsFAMA perovskite solar cells with the device structure illustrated in Figure 1b were fabricated to study the chemical valence effect of sulfur on cell performance. The surface chemical states of TiO_2 films treated with different sodium sulfides were characterized by XPS. The XPS peak at 1071.4 eV could be identified as Na 1s³³ and found in all TiO_2 films under different treatments, as shown in Figure 1c. The identical Na 1s peak position in four samples confirmed that the four treatment methods could effectively introduce Na elements into TiO_2 films and the chemical states of Na elements were the same. Figure 1d presents the binding energies of S 2p in TiO_2 films treated with different sulfides, where the standard binding energies of S^{2-} (162.8 eV) and S^{6+} (170.3 eV) were marked with two short dashed lines.³³ The S^{2-} peak could be observed in the Na_2S -treated and $\text{Na}_2\text{S}_2\text{O}_3$ -treated films separately, indicating the successful introduction of sulfides. Both the S^{2-} peak at 162.8 eV and the S^{6+} peak at 170.3 eV were observed in the XPS spectrum of $\text{Na}_2\text{S}_2\text{O}_3$ -treated TiO_2 films, indicating that the sulfur in $\text{Na}_2\text{S}_2\text{O}_3$ is composed of S^{2-} and SO_4^{2-} ions. The peak position of S 2p shifted toward the direction of low binding energy compared with that of S^{6+} in Na_2SO_4 , which may be due to the different chemical environments in the samples. In summary, increasing binding energy with an increase of sulfur valence can be observed in XPS measurements.

The I – V characteristic curves of TiO_2 films treated with four different sulfides were measured to study the influence of sulfur valence on the conductivity of TiO_2 thin films. The device structure for the conductivity measurement and the results are given in Figure 1e. The calculated conductivities of sodium sulfide-treated films were higher than those of controls, which can be attributed to the sodium dopant³⁴ (Na_2S -doped TiO_2 , 5.18 $\mu\text{S}/\text{cm}$; Na_2S spin-coated TiO_2 , 4.41 $\mu\text{S}/\text{cm}$; $\text{Na}_2\text{S}_2\text{O}_3$ spin-coated TiO_2 , 4.12 $\mu\text{S}/\text{cm}$; Na_2SO_4 spin-coated TiO_2 , 3.62

$\mu\text{S}/\text{cm}$; control, 3.35 $\mu\text{S}/\text{cm}$). The conductivity of only Na_2SO_4 -coated TiO_2 films showed a small increment, which may have resulted from the compensation of the negative effect of SO_4^{2-} ions on the conductivity of TiO_2 films.

The effects of the chemical valence of sulfur on PVK properties were investigated. The XRD patterns of perovskite films grown on TiO_2 substrates treated with different sulfides are shown in Figure 2a. The diffraction peak surrounded by the red dotted box at 12.7° corresponded to the deliberately introduced PbI_2 in the perovskite films.³⁵ Meanwhile, three diffraction peaks located at 11.56° , 26.52° , and 37.71° could be identified as those of the TiO_2 substrate,³⁶ which were noted with red arrows in Figure 2a. Diffraction peaks of perovskite samples on different substrates are found at the same position in the XRD patterns, indicating that sulfur valence has little effect on the crystallization of perovskite films. The UV–vis absorption spectra of the perovskite films on different substrates showed an absorption edge of 770 nm and were almost identical, as shown in Figure 2b, indicating that the chemical valences of sulfur have little effect on film thicknesses and light absorption properties.

Steady-state photoluminescence (PL) and time-resolved PL (TRPL) measurements are conducted to study the behavior of the photoinduced carrier at the TiO_2 /PVK interface on different TiO_2 substrates. As shown in Figure 2c, the PL intensity of the PVK layers on Na_2S -doped, Na_2S -coated, and $\text{Na}_2\text{S}_2\text{O}_3$ -coated TiO_2 substrates decreased and that of the PVK layers on the Na_2SO_4 -coated TiO_2 substrates increased compared with that of the control samples. The PL intensity increased with the average valence of sulfur in sulfide treatments. The decrease of PL intensity could be attributed to the reduction of radiative recombination and enhanced carrier extraction at the TiO_2 /PVK interface. TRPL spectra of PVK layers grown on different TiO_2 substrates are shown in Figure 2d. The fitting transient lifetimes extracted from the spectra of the control, Na_2S -doped, Na_2S -coated, $\text{Na}_2\text{S}_2\text{O}_3$ -coated, and the Na_2SO_4 -coated samples were 235, 165, 166, 209, and 333 ns, respectively. It could be found that the PVK layers deposited on the TiO_2 substrates treated with Na_2S and $\text{Na}_2\text{S}_2\text{O}_3$ have a shorter carrier lifetime than that of the control, while the lifetime of PVK layers on the TiO_2 substrates treated

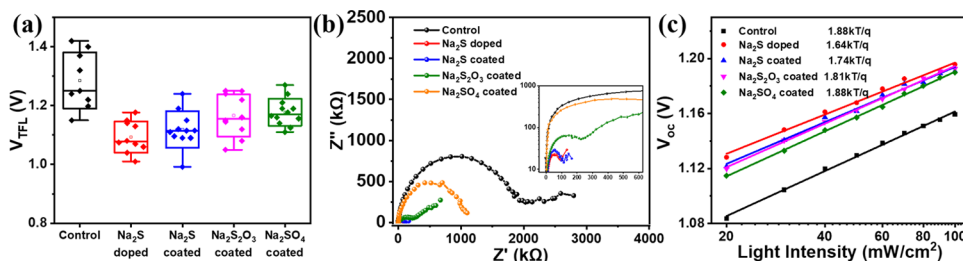


Figure 4. (a) V_{TFL} box diagram of the single-electron devices composed of TiO_2 layers treated with different sulfides. (b) EIS measurements of PSCs composed of TiO_2 layers treated with different sulfides; inset, enlarged region of (b) at a small R_{ct} . (c) Relationship between the optical density and the open-circuit voltage of PSCs composed of TiO_2 films treated with Na_2S , $\text{Na}_2\text{S}_2\text{O}_3$, and Na_2SO_4 .

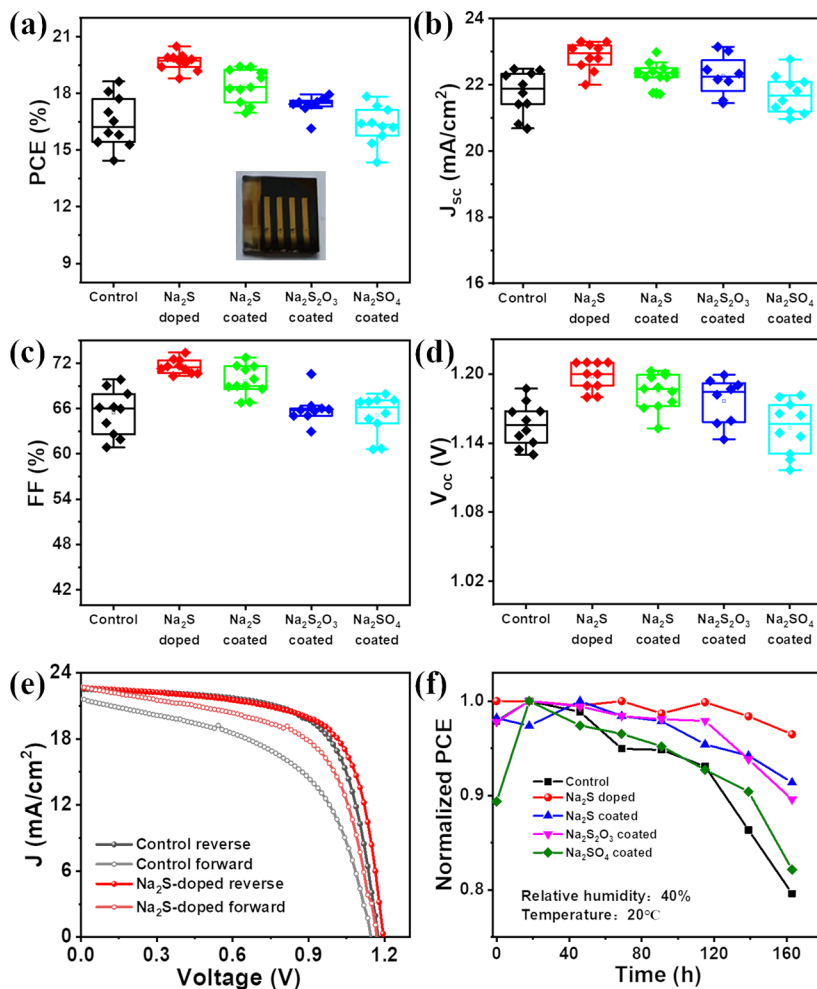


Figure 5. Box diagram of the key performance parameters of PSCs composed of TiO_2 films treated with different sulfides: (a) PCE (inset, photo of PSCs on TiO_2), (b) J_{sc} , (c) FF, and (d) V_{oc} . (e) Reverse and forward J - V curves of the control and Na_2S -doped PSCs. (f) Long-term stability of PSCs composed of TiO_2 layers treated with different sulfides.

with Na_2SO_4 was longer than that of the control. The lifetime increased with an increase of the average valence of sulfur in the sulfide. It could be concluded that the TiO_2 substrates treated with S^{2-} can improve the quality of the TiO_2 /PVK interface and the treatment of SO_4^{2-} has a negative effect on the interface.

The SEM images of the PVK layers on different substrates are shown in Figure 3, and the grain size of each sample was calculated to investigate the effects of different sulfide-treated TiO_2 substrates on morphology and grain distribution. The average grain sizes of the control, Na_2S -doped, Na_2S -coated,

$\text{Na}_2\text{S}_2\text{O}_3$ -coated, Na_2SO_4 -coated TiO_2 samples were 142, 196.6, 172.2, 162.3, and 130.5 nm, respectively, corresponding to the peak position fitted with the Gaussian distribution. As shown in Figure 3e, the perovskite films of Na_2S -doped, Na_2S -coated, and $\text{Na}_2\text{S}_2\text{O}_3$ -coated samples had larger grain sizes than those of the control, which led to an enhancement of stability and conductivity. The grain sizes of the PVK layers on the Na_2SO_4 -coated TiO_2 substrate were smaller than that of the control, which increases the number of grain boundaries of PVK layers and reduces the stability of solar cells. In addition, the SEM image of PVK layers on the Na_2SO_4 -coated TiO_2

substrates showed three obvious small defects, which may increase the roughness of the sample and capture carriers. It could be seen that the grain size of perovskite films decreased with increasing chemical valence of sulfur in TiO₂ substrate treatment. The enlargement of the grain size of the PVK layers by S²⁻ ions was consistent with the previous report,³⁷ and the SO₄²⁻ ions had little, even negative, effect on the quality of PVK layers.

In order to illustrate the effect of TiO₂ substrates treated with different sulfides on the defect state of the PVK layers, we prepared ETL-only devices and conducted space-charge-limited current (SCLC) measurements. The corresponding detailed *J*–*V* curves are shown in Figure S1, and the calculated average *V*_{TFL} values are shown in Figure 4a. The overall trend shows a reduced density of defects in sulfide-treated samples than that in the controls. The defect density of the PVK layers in the Na₂S- and Na₂S₂O₃-treated samples was reduced, which could be ascribed to the passivation of S²⁻ ions. The introduced SO₄²⁻ ions can reduce the grain size of PVK layers, as shown in Figure 3, and may induce more defects at the boundaries. The slightly reduced density of defect states in the Na₂SO₄-coated samples may be partially attributed to the passivation effects of Na⁺ ions.³⁸

EIS measurements were conducted on the cells in a dark environment to investigate the effect of chemical valences of sulfur on the carrier transport capacity at the TiO₂/PVK interface, where *R*_{ct} can reveal carrier obstruction at the interface. As shown in Figure 4b, *R*_{ct} values of the control, Na₂S-doped, Na₂S-coated, Na₂S₂O₃-coated, and Na₂SO₄-coated samples were 1602, 46, 59, 130, and 900 kΩ, respectively. A smaller *R*_{ct} value means less radiation recombination of carriers at the interface. The *R*_{ct} value of the Na₂S-doped sample was the lowest, followed by that of the Na₂S-coated sample, indicating that the doping treatment was better. The *R*_{ct} value of the Na₂S₂O₃-coated sample was relatively large but still much smaller than that of the controls, indicating that Na₂S₂O₃ treatment also has a certain improvement effect on the carrier transport at the TiO₂/PVK interface. The *R*_{ct} value of the Na₂SO₄-coated sample was smaller than that of the control, which may be attributed to the increase of the conductivity of the TiO₂ layers caused by Na⁺ ions.

The plot of *V*_{oc} versus light density in Figure 4c can qualitatively describe the defect density inside the cells and evaluate the overall performance of the devices. Light intensity is proportional to the photogenerated current, and the relationship between the open-circuit voltage and the photocurrent can be described as

$$V_{oc} = \frac{nkT}{q} \ln \left(\frac{I_{ph}}{I_0} + 1 \right)$$

where *n* is the ideal factor, *k* is the Boltzmann constant, *T* is the absolute temperature, *I*_{ph} is the photogenerated current, *I*₀ is the reverse saturation current, and *q* is the electronic charge. The calculated *n* values of samples were 1.88 (control), 1.64 (Na₂S-doped), 1.74 (Na₂S-coated), 1.81 (Na₂S₂O₃-coated), and 1.88 (Na₂SO₄-coated), which positively correlates with the defect density. The defect density of the Na₂S- and Na₂S₂O₃-treated samples decreased obviously, while that of the Na₂SO₄-treated samples was the same as that of the controls, which is consistent with the SCLC measurement results of the ETL-only devices.

To further study the effect of sulfur valences on device performance, classic planar solar cells (FTO/TiO₂/sulfides/PVK/Spiro-OMeTAD/Au) were prepared with different sodium sulfide treatments. Ten solar cells for each type of substrate were measured under AM 1.5 G (100 mW cm⁻²)-simulated solar illumination conditions, and the corresponding statistic diagram are presented in Figure 5a–d. As shown in Figure 5a, the average PCEs of cells on the Na₂S-doped, Na₂S-coated, and Na₂S₂O₃-coated TiO₂ substrates considerably improved from 16.25% to 19.62%, 18.40%, and 17.47%, respectively, while the average PCE of the Na₂SO₄-coated TiO₂ substrate was around 16.33%, suggesting that the SO₄²⁻ ions have different effects on the devices. Similar trends could be found for the parameters of *V*_{oc}, FF, and *J*_{sc}. It could be concluded that S²⁻ ions had a positive effect on device efficiency, while the SO₄²⁻ ions had little, even negative, effects. The introduction of S²⁻ greatly enhanced the *J*_{sc}, which was consistent with the decrease of the PL intensity and luminescence lifetime shown in Figure 2 and the improvement of EQE values in Figure S2f. This indicated that the introduction of S²⁻ ions can reduce the recombination of carriers and enhance the extraction capacity of carriers at the TiO₂/PVK interface. However, the *J*_{sc} of Na₂SO₄-coated devices was lower than that of the controls, indicating that SO₄²⁻ deteriorates the TiO₂/PVK interface and slightly degrades the device performance.

Figure 5e shows the reverse and forward sweep *J*–*V* curves of the control sample and the Na₂S-doped sample, and the remaining results are presented in Figure S2. The control sample gave an obvious hysteresis from the reverse to the forward scans, while the Na₂S-doped one showed a marked reduction of the hysteresis, resulting in an improvement of the electrical conductivity of the TiO₂ layer and a reduced interface carrier recombination of the TiO₂/PVK interface. As expected, the Na₂SO₄-doped sample showed little improvement in the hysteresis due to the poor effect of SO₄²⁻ on the interface.

We further explored the effect of different sulfide treatments on the performance stability of unencapsulated solar cells. As expected, the samples treated with lower-valence sulfide demonstrated better long-term air stability, as shown in Figure 5f. The Na₂S-doped sample could still maintain 96.5% of the initial PCE after 163 h of exposure in the air condition, 91.4% for the Na₂S-coated sample, 89.6% for the Na₂S₂O₃-coated sample, 82.1% for the Na₂SO₄-coated sample, while only 79.6% for the control sample. The stability of the cells improved after the introduction of Na₂S and Na₂S₂O₃ into the TiO₂ layer, while the stability did not improve after the introduction of Na₂SO₄. This is consistent with the previous experimental results that the S²⁻ ions have obvious improvement effects on the TiO₂/PVK interfaces and the PVK layers, while SO₄²⁻ ions have little effect on the interface and the PVK layer. The slight improvement in the performance of Na₂SO₄-coated samples could be attributed to the increase of conductivity of TiO₂ layers by Na⁺ ions.

CONCLUSIONS

In summary, we adopted sulfides with different chemical valences to modify the TiO₂ layer and investigated their impacts on the properties of the TiO₂/PVK interfaces and PVK layers and the performance of corresponding CsFAMA solar cells. The Na₂S- and Na₂S₂O₃-treated TiO₂ layers could enhance the carrier extraction capacity at the TiO₂/PVK

interface due to the introduction of Na^+ and S^{2-} . The Na_2S - and $\text{Na}_2\text{S}_2\text{O}_3$ -treated TiO_2 layers led to the improved crystal quality of the PVK layers in terms of grain size, reduced defect density and dark current, and improved hysteresis effect and device stability. Meanwhile, Na_2SO_4 -modified TiO_2 layers had no significant effect on the carrier extraction ability at the TiO_2 /PVK interface and even negative effects on the morphology of the following PVK layers. As a result, the cell performance showed a slight improvement compared with the control sample. This work may provide insights into choosing sulfides and proper chemical valences to modify the TiO_2 /PVK interfaces.

EXPERIMENTAL SECTION

Solution Preparation. The pure TiO_2 precursors were prepared by dissolving tetrabutyl titanate (250 μL , Sigma-Aldrich) and hydrochloric acid (25 μL , Kelong) in absolute ethyl alcohol (3 mL, Aladdin). For Na_2S -doped TiO_2 precursors, absolute ethyl alcohol (Aladdin)-dissolved anhydrous Na_2S (Aladdin), according to the molar ratio of Na_2S and TiO_2 , was added into the prepared pure TiO_2 precursors. The sulfide coating precursors were prepared by dissolving different sulfides (Na_2S (Aladdin), $\text{Na}_2\text{S}_2\text{O}_3$ (Aladdin), and Na_2SO_4 (Aladdin)) in absolute ethyl alcohol (Aladdin) according to the concentration of sulfides. The $\text{Cs}_{0.1}(\text{MA}_{0.15}\text{FA}_{0.85})_{0.9}\text{Pb}(\text{Br}_{0.15}\text{I}_{0.85})_3$ precursors were prepared by mixing five components in 700 μL of DMF and 300 μL of DMSO according to the proportion. The components consisted of cesium iodide (CsI, 31.2 mg, Alfa Aesar), methylammonium bromide (MABr, 18.1 mg, lumtec), lead bromide (PbBr_2 , 66.1 mg, Sigma-Aldrich), formamidinium iodide (FAI, 157.9 mg, luminescence), and lead iodide (PbI_2 , 470.2 mg, Sigma-Aldrich). The Spiro-OMeTAD solutions were prepared by mixing chlorobenzene (1 mL, Alfa Aesar)-dissolved 2,2',7,7'-tetrakis[N,N -di(4-methoxyphenyl)amino]-9,9'-spirobifluorene (Spiro, 72.3 mg, luminescence), 4-tert-butylpyridine (28.8 μL , Sigma-Aldrich), and Li-TFSI solution (17.5 μL , Li-TFSI (520 mg, Sigma-Aldrich) in acetonitrile (1 mL, Alfa Aesar) and Co(III) TFSI salt solution (60 μL , FK209 Co(III) TFSI salt (100 mg, luminescence) in chlorobenzene (1 mL, Alfa Aesar)). Both perovskite precursors and Spiro-OMeTAD solutions should be kept in a glovebox overnight at room temperature. PCBM (20 mg, Baolait Industrial Co.) was dissolved in acetonitrile (1 mL, Alfa Aesar).

Device Fabrication. The FTO glass (sheet resistance = 7 $\Omega \text{ sq}^{-1}$) was sequentially cleaned with detergent, deionized water, acetone, and ethyl alcohol in an ultrasonicator for 20 min, then dried with a nitrogen gun, and treated by plasma cleaning for 15 min. The TiO_2 - or Na_2S -doped TiO_2 compact layers were prepared by spin coating the TiO_2 - or Na_2S -doped TiO_2 precursor solution onto the FTO substrates at 5000 rpm for 30 s in the air. Then, the samples were preannealed at 120 $^\circ\text{C}$ for 20 min on a hot plate and heated in a muffle oven at 450 $^\circ\text{C}$ for 1 h to form the $c\text{-TiO}_2$ layers. For the Na_2S -, $\text{Na}_2\text{S}_2\text{O}_3$ -, or Na_2SO_4 -coated samples, the corresponding precursor solutions were spin-coated onto the compact TiO_2 layers at 5000 rpm for 30 s in the air and annealed at 120 $^\circ\text{C}$ for 20 min on the hot plate to form the interfacial layers. Samples were treated with plasma cleaning for 15 min before the PVK deposition process and then transferred into a glovebox. PVK layers were deposited rapidly by a one-step spin coating process at 500 rpm for 5 s and 5000 rpm for 50 s on FTO/ $c\text{-TiO}_2$ substrates, and 50 μL of chlorobenzene (Alfa

Aesar) was injected onto the spinning substrate constantly. All samples were then annealed at 150 $^\circ\text{C}$ for 10 min covered with a Petri dish. The Spiro-OMeTAD precursor was then deposited on PVK layers by spin coating at 5000 rpm for 50 s. At last, 80 nm thick Au electrodes were deposited on the devices by vacuum thermal evaporation.

Characterization. The I - V measurements and stability tests were performed on a Keithley 2400 digital source meter under simulated sunlight from a Newport 94123A solar simulator matching the AM 1.5G irradiation (100 mW cm^{-2}). The devices were measured from 1.4 to -0.2 V at a scan rate of 10 mV/s . X-ray photoelectron spectroscopy (XPS) was carried out on a PHI 5000 Versa Probe III. UV-vis absorption spectra were recorded with a Youke UV-1901 UV-vis spectrometer. SCLC and conductivity were tested on a Keithley 2400 digital source meter. SEM images were recorded on a field-emission scanning electron microscopy (FEI inspect) instrument at an acceleration voltage of 8 kV. Steady-state photoluminescence (PL) and time-resolved PL (TRPL) spectra were recorded using an Edinburgh Instruments FLS 980 equipped with a light source with an excitation wavelength of 375 nm. EIS plots were constructed on a CorrTest Electrochemical Workstation under dark conditions.

The formula for calculating the conductivity of the TiO_2 substrates can be described as

$$\sigma = ID(AV)^{-1}$$

where σ is the conductivity of the sample, I and V are the measured current and voltage, respectively, A is the area of the measured sample, which is 5.5 mm^2 , and D represents the thickness of the TiO_2 layer, which is 30 nm for each sample.

ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge at <https://pubs.acs.org/doi/10.1021/acsomega.3c01694>.

Dark J - V characteristic curves of the single-electron devices, reverse and forward J - V curves, and EQE measurement of solar cells (PDF)

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Author Contributions

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Notes

The authors declare no competing financial interest.

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